# COM304 COMPUTER ARCHITECTURE

10 January 2019

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## COM304 Course Evaluation

- □ Pre End Semester: 40% weightage
  - □ Quiz 1 20% weightage
  - □ Quiz 2 20% weightage
- End semester: 60% Weightage
  - End Sem Exam 60% weightage
- Solution to Open Challenges will be graded 'S'

# Syllabus

- Fundamentals of computer design: Classes of computers, trends in technology, measurement of performance of a computer system, current issues in design of functional components of a computer system Processor unit, memory unit, and secondary storage unit; Hardware/software tradeoff in computer design
- Fundamentals of processor design: Instruction set processor design, exploitation of instruction level parallelism, processor micro architecture, performance of a processor
- Pipelined processor architecture: Fundamentals of pipelining, arithmetic pipeline design – Carry look ahead adder, Wallace tree multiplier, Floating-point adder/subtractor;
- Instruction pipeline design; Balancing pipeline stages; Stalls in a pipeline; Methods for reductions of stalls in a pipelined processor

# Syllabus Contd.,

- Superscalar processor architecture: Limitations of scalar pipelines, superscalar pipelines, dynamic exploitation of instruction—Level parallelism, register dataflow techniques, memory dataflow techniques, Instruction flow techniques, case studies of superscalar processors
- Advanced processor architectures: Multithreaded processors, multi core processors, reconfigurable instruction set processors
- Storage system architectures: RAID architecture, storage area networks, Network attached storage
- Large computer system architectures: Symmetric multiprocessor systems Shared memory systems and shared bus architectures; cache coherency protocols MESI protocol and coherence in multi–level cache systems; Internetwork architectures Directory protocol for cache coherence

## Reference Books

- Hennessy J.H and Patterson D.A, Computer
   Architecture A Quantitative Approach, Morgan Kaufmann, 2003.
- Shen J.P and Lipasti M.H, Modern Processor Design Fundamentals of Superscalar Processors, Tata McGraw Hill, 2003.

#### □ 100% Attendance must

DAY	Time
Monday	08:00-08:50
Thursday	12:00-12:50
Friday	09:00-09:50

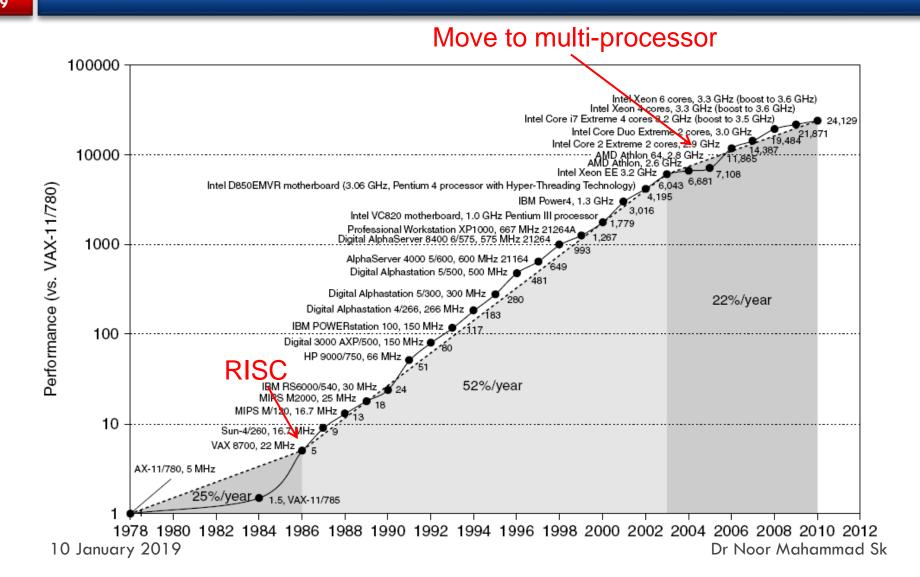
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## Fundamentals of Computer Design

## Computer Technology

- Performance improvements:
  - Improvements in semiconductor technology:
    - Feature size, clock speed
  - Improvements in computer architecture
    - Enabled by HLL compilers, UNIX
    - Lead to RISC architectures
- Together have enabled:
  - Lightweight computers
  - Productivity based managed/interpreted programming languages

## Single Processor Performance



## **Current Trends in Architecture**

- Cannot continue to leverage instruction-level parallelism (ILP)
  - Single processor performance improvement ended in 2003
- New models for performance
  - Data level parallelism (DLP)
  - Thread-level parallelism (TLP)
  - Request-level Parallelism (RLP)
- These require explicit restructuring of the application

## Classes of Computers

- Personal Mobile Devices (PMD)
  - e.g., smart phones, tablet computers
  - Emphasis on energy efficient and real-time
- Desktop Computing
  - Emphasis on price-performance
- Servers
  - Emphasis on availability, scalability and throughput
- Clusters/warehouse scale computers
  - Used for "Software as a Service (SaaS)"
  - Emphasis on availability and price-performance
  - Subclass: Super computers
    - Emphasis: floating-point performance and fast internal networks
- Embedded Computers
  - Emphasis: price

#### Parallelism

- Classes of parallelism in applications:
  - Data-Level Parallelism (DLP)
  - Task-Level Parallelism (TLP)
- Classes of architectural parallelism:
  - Instruction-Level Parallelism (ILP)
  - Vector architecture/Graphic Processor Units (GPUs)
  - Thread-Level Parallelism
  - Request-Level Parallelism

# Flynn's Taxonomy

- Single instruction stream, single data stream (SISD)
- Single instruction stream, multiple data streams (SIMD)
  - Vector architectures
  - Multimedia extensions
  - Graphics processor units
- Multiple instruction streams, single data stream (MISD)
  - No commercial implementation
- Multiple instruction streams, multiple data streams (MIMD)
  - Tightly-coupled MIMD
  - Loosely-coupled MIMD

## Defining Computer Architecture

- "Old" view of computer architecture:
  - Instruction set architecture (ISA) design
  - i.e., decisions regarding
    - Registers, memory addressing, addressing modes, instruction operands, available operations, control flow instruction, instruction encoding
- "Real" computer architecture:
  - Specific requirements of the target machine
  - Design to maximize performance within constraints:
    - Cost, power and availability
  - □ Includes ISA, micro-architecture, hardware

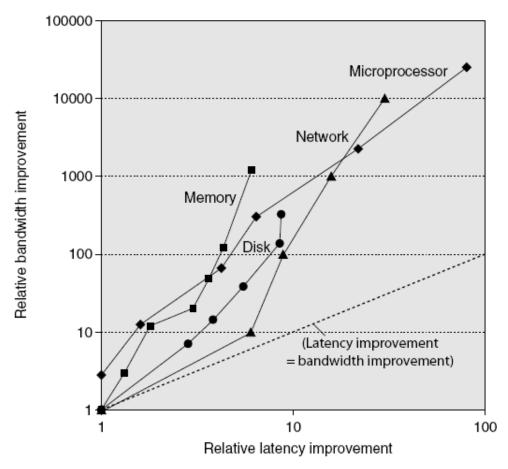
## Trends in Technology

- Integrated circuit technology
  - Transistor density: 35%/year
  - □ Die size: 10-20%/year
  - □ Integration overall: 40 55%/year
- DRAM capacity: 25–40 % (slowing)
- □ Flash capacity: 50-60%/year
  - 15 20x cheaper/bit than DRAM
- Magnetic disk technology: 40%/year
  - 15 25x cheaper/bit than Flash
  - 300 500x cheaper/bit than DRAM

## Bandwidth and Latency

- Bandwidth or throughput
  - Total work done in a given time
  - □ 10,000 25,000x improvement for processors
  - 300 1200x improvement for memory and disks
- Latency or response time
  - Time between start and completion of an event
  - 30 80x improvement for processors
  - □ 6 8x improvement for memory and disks

## Bandwidth and Latency



Log-log plot of bandwidth and latency milestones

#### **Transistors and Wires**

- Feature Size
  - Minimum size of transistor or wire in x or y dimension
  - 10 micros in 1971 to 0.032 microns in 2011
  - Transistor performance scales linearly
    - Wire delay does not improve with feature size!
  - Integration density scales quadratically

## Power and Energy

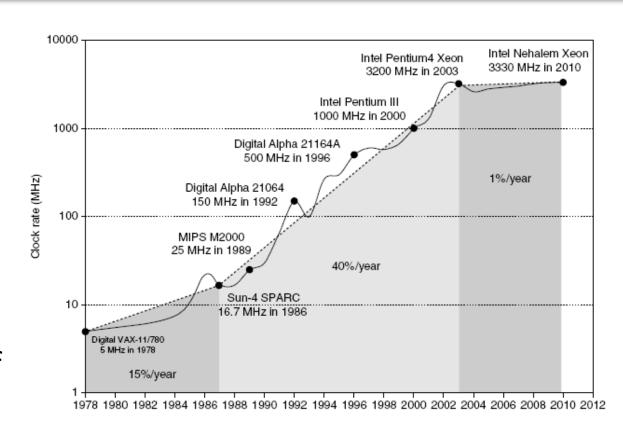
- Problem: Get power in, Get power out
- Thermal Design Power (TDP)
  - Characterizes sustained power consumption
  - Used as target for power supply and cooling system
  - Lower than peak power, higher than average power consumption
- Clock rate can be reduced dynamically to limit power consumption
- Energy per task is often a better measurement

## Dynamic Energy and Power

- Dynamic energy
  - $\blacksquare$  Transistor switch from  $0 \rightarrow 1$  or  $1 \rightarrow 0$
  - ½ x Capacitive load x Voltage<sup>2</sup>
- Dynamic power
  - ½ x Capacitive load x Voltage<sup>2</sup> x Frequency switched
- Reducing clock rate reduces power, not energy

#### Power

- □ Intel 80386 consumed ~ 2 W
- 3.3 GHz IntelCore i7 consumes130 W
- Heat must be dissipated from 1.5 x 1.5 cm chip
- This is the limit of what can be cooled by air



## Reducing Power

- Techniques for reducing power:
  - Dynamic voltage frequency scaling
  - Low power state for DRAM, disks
  - Overclocking, turning off cores

#### Static Power

- Static power consumption
  - Current<sub>static</sub> x Voltage
  - Scales with number of transistors
  - To reduce: power gating

#### Trends in Cost

- Cost driven down by learning curve
  - Yield

- DRAM: price closely tracks cost
- Microprocessors: price depends on volume
  - 10% less for each doubling of volume

## Integrated Circuit Cost

#### Integrated Circuit

Cost of Integrated Circuit = 
$$\frac{\text{Cost of die} + \text{Cost of testing die} + \text{Cost of packaging and final test}}{\text{Final test yield}}$$

$$\text{Cost of die} = \frac{\text{Cost of Wafer}}{\text{Die per wafer x Die yield}}$$

$$\text{Dies per wafer} = \frac{\pi \times (\text{Wafer diameter/2})^2}{\text{Die area}} - \frac{\pi \times \text{Wafer diameter}}{\sqrt{2 \times \text{Die area}}}$$

Bose-Einstein formula:

Die yield = Wafer yield 
$$\times 1/(1 + Defects per unit area \times Die area)^N$$

- Defects per unit area = 0.016 0.057 defects per square cm (2010)
- $\square$  N = process-complexity factor = 11.5 15.5 (40mm, 2010)

## Dependability

- Module reliability
  - Mean time to failure (MTTF)
  - Mean time to repair (MTTR)
  - Mean time between failures (MTBF) = MTTF + MTTR
  - Availability = MTTF / MTBF

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## Measuring Performance

- Typical performance metrics:
  - Response time
  - Throughput
- Speedup of X relative to Y
  - Execution time<sub>Y</sub> / Execution time<sub>X</sub>
- Execution time
  - Wall clock time: includes all system overheads
  - CPU time: only computation time
- Benchmarks
  - Kernels (e.g. matrix multiply)
  - Toy programs (e.g. sorting)
  - Synthetic benchmarks (e.g. Dhrystone)
  - Benchmark suites (e.g. SPEC06fp, TPC-C)

## Principles of Computer Design

- □ Take Advantage of Parallelism
  - e.g. multiple processors, disks, memory banks, pipelining, multiple functional units
- Principle of Locality
  - Reuse of data and instructions
- Focus on the Common Case
  - Amdahl's Law

Execution time<sub>new</sub> = Execution time<sub>old</sub> 
$$\times \left( (1 - \text{Fraction}_{\text{enhanced}}) + \frac{\text{Fraction}_{\text{enhanced}}}{\text{Speedup}_{\text{enhanced}}} \right)$$

Speedup<sub>overall</sub> =  $\frac{\text{Execution time}_{\text{old}}}{\text{Execution time}_{\text{new}}} = \frac{1}{(1 - \text{Fraction}_{\text{enhanced}}) + \frac{\text{Fraction}_{\text{enhanced}}}{\text{Speedup}_{\text{enhanced}}}}$ 

# Principles of Computer Design

#### The Processor Performance Equation

CPU time = CPU clock cycles for a program × Clock cycle time

$$CPU time = \frac{CPU \ clock \ cycles \ for \ a \ program}{Clock \ rate}$$

$$CPI = \frac{CPU \text{ clock cycles for a program}}{Instruction count}$$

CPU time = Instruction count  $\times$  Cycles per instruction  $\times$  Clock cycle time

$$\frac{\text{Instructions}}{\text{Program}} \times \frac{\text{Clock cycles}}{\text{Instruction}} \times \frac{\text{Seconds}}{\text{Clock cycle}} = \frac{\text{Seconds}}{\text{Program}} = \text{CPU time}$$

## Principles of Computer Design

Different instruction types having different CPIs

CPU clock cycles = 
$$\sum_{i=1}^{n} IC_i \times CPI_i$$

CPU time = 
$$\left(\sum_{i=1}^{n} IC_{i} \times CPI_{i}\right) \times Clock cycle time$$